

100325

Low Power Hex ECL-to-TTL Translator

General Description

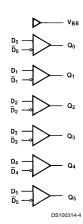
The 100325 is a hex translator for converting F100K logic levels to TTL logic levels. Differential inputs allow each circuit to be used as an inverting, non-inverting or differential receiver. An internal reference voltage generator provides V_{BB} for single-ended operation, or for use in Schmitt trigger applications. All inputs have 50 k Ω pull-down resistors. When the inputs are either unconnected or at the same potential the outputs will go low.

When used in single-ended operation the apparent input threshold of the true inputs is 20 mV to 40 mV higher (positive) than the threshold of the complementary inputs. The $\rm V_{EE}$ and $\rm V_{TTL}$ power may be applied in either order.

Features

- Pin/function compatible with 100125
- Meets 100125 AC specifications
- 50% power reduction of the 100125
- Differential inputs with built in offset
- Standard FAST® outputs
- 2000V ESD protection
- -4.2V to -5.7V operating range
- Available to Microcircuit Drawing (SMD) 5962-9153101

Logic Diagram

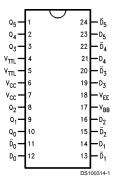


Pin Names	Description
D ₀ -D ₅	Data Inputs
$\overline{D}_0 - \overline{D}_5$	Inverting Data Inputs
Q ₀ -Q ₅	Data Outputs

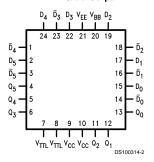
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Connection Diagrams

24-Pin DIP



24-Pin Quad Cerpak



Truth Table

Inp	uts	Outputs
D _n	\overline{D}_n	Q _n
L	Н	L
Н	L	Н
L	L	L
Н	Н	L
Open	Open	L
Open V _{EE}	V_{EE}	L
L	V_{BB}	L
Н	V_{BB}	Н
V_{BB}	L	н
V_{BB}	Н	L

H = HIGH Voltage Level L = LOW Voltage Level

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Above which the useful life may be impaired.

 V_{TTL} Pin Potential to Ground Pin -0.5V to +6.0V Input Voltage (DC) V_{EE} to +0.5V

Voltage Applied to Output

in HIGH State (with V_{CC} = 0V)

–0.5V to $V_{\rm CC}$

Current Applied to Output

in LOW State (Max) ESD (Note 2)

twice the rated I_{OL} (mA) \geq 2000V

Recommended Operating Conditions

Case Temperature (T_C)

Military

-55°C to +125°C

Supply Voltage (V_{EE})

-5.7V to -4.2V

Note 1: Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Military Version

DC Electrical Characteristics

 $V_{EE} = -4.2 \text{V to } -5.7 \text{V}, V_{CC} = V_{CCA} = \text{GND}, T_{C} = -55 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}, C_{L} = 50 \text{ pF}, V_{TTL} = +4.5 \text{V to } +5.5 \text{V}$

Symbol	Parameter	Min	Max	Units	T _C	Conditions		Notes
V _{BB}	Output Reference Voltage	-1380	-1260		0°C to +125°C	I _{VBB} = -3 μA, V _{EE} = -	-4.2V	
				mV		I _{VBB} = -2.1 mA	V _{EE} = −5.7V	(Notes 3, 4, 5)
		-1396	-1260	1	−55°C	I _{VBB} = -3 mA	1	., -,
V _{IH}	Input HIGH Voltage	-1165	-870	mV	-55°C to +125°C	Guaranteed HIGH Sig	gnal for All Inputs	(Notes 3,
						(with One Input Tied	to V _{BB})	4, 5, 6)
V_{IL}	Input LOW Voltage	-1830	-1475	mV	-55°C to +125°C	Guaranteed LOW Sig	nal for All Inputs	(Notes 3,
						(with One Input Tied	to V _{BB})	4, 5, 6)
V_{OH}	Output HIGH Voltage	2.5		mV	0°C to +125°C	I _{OH} = -2.0 mA	V _{IN} = V _{IH (Max)}	
		2.4			−55°C		or V _{IL (Min)}	(Notes 3, 4, 5)
V_{OL}	Output LOW Voltage		0.5	mV	-55°C to +125°C	I _{OL} = 20 mA		, -,
V_{DIFF}	Input Voltage Differential	150		mV	-55°C to +125°C	Required for Full Out	(Notes 3, 4, 5)	
V _{CM}	Common Mode Voltage	-2000	-500	mV	-55°C to +125°C			(Notes 3, 4, 5, 6)
I _{IH}	Input HIGH Current		350	μA	0°C to +125°C	V _{IN} = V _{IH} (Max), D ₀ -D ₅ = V _{BB} ,		(Notes 3,
			500		−55°C	$\overline{D}_0 - \overline{D}_5 = V_{IL (Min)}$		4, 5)
I _{IL}	Input LOW Current	0.50		μA	-55°C to +125°C	V _{IN} = V _{IL (Min)} , D ₀ -D ₅	= V _{BB}	(Notes 3, 4, 5)
Ios	Output Short Circuit	-150	-60	mA	-55°C to +125°C	V _{OUT} = GND		(Notes 3,
	Current					Test One Output at a	Time	4, 5)
I _{CEX}	Output HIGH		250	μA	-55°C to +125°C	V _{OUT} = 5.5V		(Notes 3,
	Leakage Current							4, 5)
I _{EE}	V _{EE} Power Supply Current	-35	-12	mA	-55°C to +125°C	$D_0 - D_5 = V_{BB}$		(Notes 3, 4, 5)
I _{TTL}	V _{TTL} Power Supply Current		65	mA	-55°C to +125°C	D_0 - D_5 = V_{BB}		(Notes 3, 4, 5)

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

Note 5: Sample tested (Method 5005, Table I) on each manufactured lot at -55°C, + 25°C, and +125°C, Subgroups A1, 2, 3, 7, and 8.

Note 6: Guaranteed by applying specified input condition and testing V_{OH}/V_{OL}.

AC Electrical Characteristics

 $V_{\rm EE}$ = -4.2V to -5.7V, $V_{\rm CC}$ = GND, $V_{\rm TTL}$ = +4.5V to +5.5V

Symbol	Parameter	T _C = -55°C		T _C = +25°C		T _C = +125°C		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t _{PLH}	Propagation Delay	1.50	5.00	1.60	4.70	1.70	5.70	ns	C _L = 50 pF	(Notes 7,
t _{PHL}	Data to Output								Figures 1, 3	8, 9)

Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 8: Screen tested 100% on each device at +25°C, temperature only, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each manufactured lot at +25°C, Subgroup A9, and at +125°C and -55°C temperatures, Subgroups A10 and A11.

Note 10: Not tested at +25 $^{\circ}$ C, +125 $^{\circ}$ C, and -55 $^{\circ}$ C temperature (design characterization data).

Switching Waveform

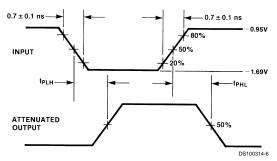
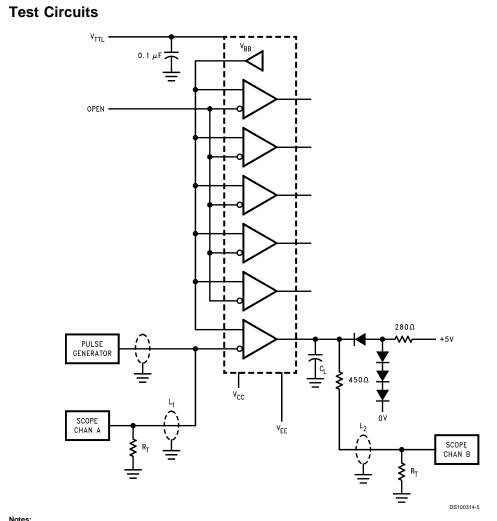


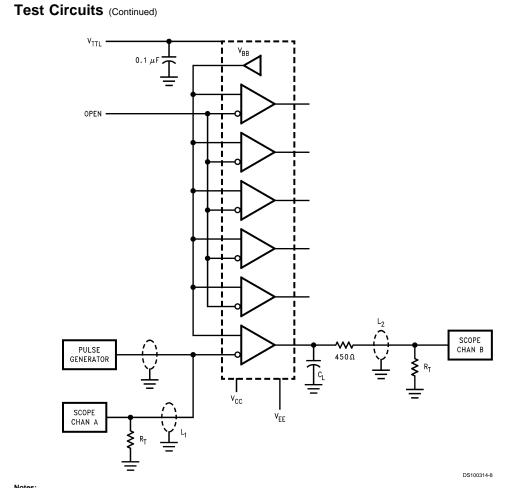
FIGURE 1. Propagation Delay



Notes:

Notes:
$$\begin{split} &V_{CC} = \text{OV}, \, V_{EE} = -4.5\text{V}, \, V_{TTL} = +5\text{V} \\ &L1 \text{ and } L2 = \text{equal length } 50\Omega \text{ impedance lines} \\ &R_T = 50\Omega \text{ terminator internal to scope} \\ &\text{Decoupling } 0.1 \, \mu\text{F from GND to } V_{CC}, \, V_{EE} \text{ and } V_{TTL} \\ &\text{All unused outputs are loaded with } 500\Omega \text{ to GND} \\ &C_L = \text{Fixture and stray capacitance} = 15 \, \text{pF} \end{split}$$

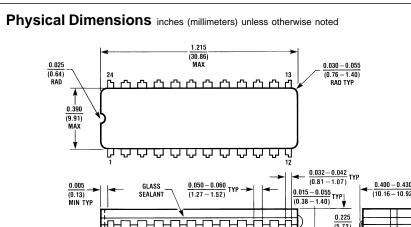
FIGURE 2. AC Test Circuit for 15 pF Loading

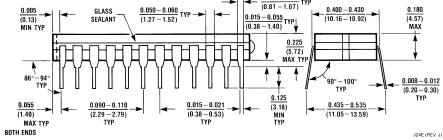


Notes:

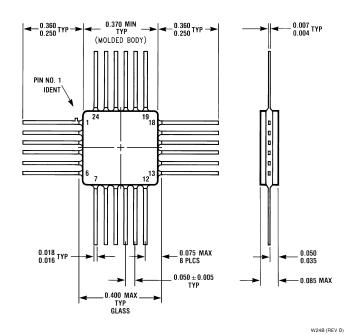
$$\label{eq:continuity} \begin{split} & \text{Notes:} \\ & V_{\text{CC}} = \text{0V}, \, V_{\text{EE}} = -4.5\text{V}, \, V_{\text{TTL}} = +5\text{V} \\ & \text{L1 and L2} = \text{equal length } 50\Omega \text{ impedance lines} \\ & R_{\text{T}} = 50\Omega \text{ terminator internal to scope} \\ & \text{Decoupling } 0.1 \, \mu\text{F from GND to } V_{\text{CC}}, \, V_{\text{EE}} \text{ and } V_{\text{TTL}} \\ & \text{All unused outputs are loaded with } 500\Omega \text{ to GND} \\ & C_{\text{L}} = \text{Fixture and stray capacitance} = 50 \, \text{pF} \end{split}$$

FIGURE 3. AC Test Circuit for 50 pF Loading





24 Lead Ceramic Dual-In-Line Package (0.400" Wide) (D) NS Package Number J24E



24 Lead Quad Cerpak (F) NS Package Number W24B

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100325 Product Folder

Low Power Hex ECL-to-TTL Translator

<u>General</u>	Features	Datasheet	<u>Package</u>	<u>Samples</u>
<u>Description</u>	reatures	Datasneet	<u>& Models</u>	<u>& Pricing</u>

Datasheet

Title	Size in Kbytes	Date	View Online	Download	Receive via Email
100325 Low Power Hex ECL-to- TTL Translator	125 Kbytes	17-Aug-98	View Online	Download	Receive via Email
100325 Mil-Aero Datasheet MN100325-X	106 Kbytes		View Online	Download	Receive via Email

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Part Number	Package		Status	Mod	els	Samples & Electronic	Budgetary Pricing		Std Pack	Package Marking	
	Туре	Pins	MSL		SPICE	IBIS	Orders	Qty	\$US each	Size	Marking
5962-9153101MXA	CERDIP	24	MSL	Full production	N/A	N/A	Buy Now	50+	\$37.6000	rail of 15	[logo]¢Z¢S¢4¢A\$E 100325DMQB /Q 5962- 9153101MXA
5962-9153101MYA	CERQUAD	24	MSL	Full production	N/A	N/A	Buy Now	50+	\$45.2000	rail of 14	[logo]¢Z¢S¢4¢A Q\$E 100325 FMQB 5962 -9153101 MYA
5962-9153101VXA	CERDIP	24	MSL	Full production	N/A	N/A		50+	\$265.0000	rail of 15	[logo]¢Z¢S¢4¢A\$E 100325J-QMLV 5962-9153101VXA
100325WFQMLV	CERQUAD	24	MSL	Preliminary	N/A	N/A				rail of N/A	[logo]¢Z¢S¢4¢A 100325WF QMLV 5962 F9153101 VYA\$E
RM100325WFQMLV	CERQUAD	24	MSL	Preliminary	N/A	N/A				rail of N/A	[logo]¢Z¢S¢4¢A RM100325WF QMLV WFR# ¢R \$E

5962-9153101VYA	CERQUAD 24	4 MSL	Full production	N/A	N/A	5	50+	\$265.0000	rail of 14	[logo]¢Z¢S¢4¢A 100325W- QMLV 5962 -9153101 VYA \$E
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[Information as of 5-Aug-2002]

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